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CLAIMS 1-13 CANCELED

14. (Amended) A method of predicting electrical behavior of a device in electrical context with one or more circuits comprising the steps of:
- obtaining a device S-parameter matrix ( $S_D$ ) having matrix elements that characterize high frequency behavior of said device, said device having a number of device ports,
- establishing a single adapter T-parameter matrix ( $T_A$ ) having matrix elements that represent transmission parameters for all possible paths in a combination of the one or more circuits,
- partitioning said adapter T-parameter matrix into four sub-matrices, and
- solving for a cascaded S-parameter matrix ( $S_C$ ) that represents the one or more circuits cascaded with the device as a function of said four sub-matrices and said device S-parameter matrix, ~~and~~
- ~~verifying resulting values in said cascaded S-parameter matrix against a desired result.~~
15. (Original) A method as recited in claim 14 and further comprising the step of

preparing a design for the device embedded in electrical context with said one or more circuits.

16. (Original) A method as recited in claim 14 wherein a model for said one or more circuits has twice said number of device ports.
17. (Original) A method as recited in claim 16 wherein said step of partitioning comprises splitting said adapter T-parameter matrix into respective first ( $T_{a11}$ ), second ( $T_{a12}$ ), third ( $T_{a21}$ ), and fourth ( $T_{a22}$ ) T-parameter sub-matrix and solving for said cascaded S-parameter matrix using the equation:

$$(T_{a11}S + T_{a12})(T_{a21}S + T_{a22})$$

18. (Original) A method as recited in claim 14 wherein said device has an odd number of device ports.
19. (Original) A method of designing as recited in claim 18 wherein said step of establishing said adapter T-parameter matrix comprises modeling said device with an additional device port and including as part of said adapter T-parameter matrix a representation of electrical behavior of a zero length, loss-less transmission line connected to said additional device port and terminated in a perfect load.

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30. (Original) An apparatus for characterizing electrical behavior of a device embedded in one or more circuits comprising:
  - a computing device,
  - a vector network analyzer,

means executing on said computing device for establishing a device S-parameter matrix to represent the device, an adapter T-parameter matrix to represent all possible electrical paths from said vector network analyzer through said one or more circuits to said device, and a cascaded S-parameter matrix to represent said one or more circuits cascaded with said device,

means for transferring measurements made on said vector network analyzer for said one or more circuits into elements of said adapter T-parameter matrix and for said one or more circuits cascaded with said device into elements of said cascaded S-parameter matrix, and

means for solving for said device S-parameter matrix as a function of said adapter T-parameter matrix and said cascaded S-parameter matrix.

31. (Original) An apparatus for characterizing as recited in claim 30 wherein said means executing on said computing device further comprises means for establishing an adapter S-parameter matrix to represent said all possible paths from said vector network analyzer through said one or more circuits to said device, means for transferring measurements made by said vector network analyzer to elements in said adapter S-parameter matrix, and means executing on said computing device for converting said resulting S-parameter matrix to said adapter T-parameter matrix.
32. (Original) An apparatus for characterizing as recited in claim 30 wherein said means for solving further comprises

means for partitioning said adapter S-parameter matrix into first ( $S_{a11}$ ), second ( $S_{a12}$ ), third ( $S_{a21}$ ), and fourth ( $S_{a22}$ ) sub-matrices, means for converting each said sub-matrix into a respective first ( $T_{a11}$ ), second ( $T_{a12}$ ), third ( $T_{a21}$ ), and fourth ( $T_{a22}$ ) transmission parameter sub-matrix, and means for solving for said device S-parameter matrix using the equation:

$$(T_{a11} - S_c T_{a21})^{-1} (S_c T_{a22} - T_{a12}).$$

33. (Original) An apparatus for characterizing as recited in claim 30 wherein said device S-parameter matrix represents a device having a number of device ports and said adapter T-parameter matrix represents an adapter having twice as many adapter ports as said device ports.
34. (Original) An apparatus for characterizing as recited in claim 30 wherein said number of device ports is odd.
35. (Original) An apparatus for characterizing as recited in claim 34 wherein said cascaded S-parameter matrix comprises scattering parameter variables in as many rows as there are device ports and as many columns as there are device ports, said cascaded S-parameter matrix further comprising an additional row containing zero values for each matrix element in said additional row and an additional column containing zero values for each matrix element in said additional column.

36. (Original) An apparatus for characterizing as recited in claim 34 wherein said means for establishing said adapter T-parameter matrix comprises means for modeling said device with an additional device port and including as part of said adapter T-parameter matrix values that reflect a zero length, loss-less transmission line connected to said additional device port and terminated in a perfect load.
37. (Original) An apparatus for characterizing as recited in claim 36 wherein said means for measuring said one or more circuits further comprises means for establishing an adapter S-parameter matrix to represent said all possible paths from said measuring device through said one or more circuits including said zero-length, loss-less transmission line, means for measuring to obtain values for said adapter S-parameter matrix and inserting appropriate values to represent said zero-length, loss-less transmission line, and means for converting said resulting S-parameter matrix to said adapter T-parameter matrix.
38. (Original) An apparatus for characterizing as recited in claim 30 wherein said vector network analyzer is responsive to instructions from said computing device to performing measurements to obtain values for elements in said adapter T-parameter matrix and said cascaded S-parameter matrix.
39. (Original) An apparatus for designing a device embedded in electrical context with one or more circuits comprising:  
a computing device,

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means for obtaining values for a device S-parameter matrix ( $S_D$ ) having matrix elements that characterize high frequency behavior of said device, wherein said device S-parameter matrix represents a device having a number of device ports,

means executing on said computing device for establishing a single adapter T-parameter matrix ( $T_A$ ) having matrix elements that represent transmission parameters for all possible electrical paths in said one or more circuits,

means executing on said computing device for partitioning said adapter T-parameter matrix into four sub-matrices, and

means executing on said computing device for solving a cascaded S-parameter matrix ( $S_C$ ) that represents the one or more circuits cascaded with the device as a function of said four sub-matrices and said device S-parameter matrix.

40. (Original) An apparatus as recited in claim 39 and further comprising means for building said device as embedded in a circuit represented by said single adapter.
41. (Original) An apparatus as recited in claim 39 wherein a model for said one or more circuits has twice said number of device ports.

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42. (Original) An apparatus as recited in claim 41 wherein said means executing on said computing device for partitioning further comprises means on said computing device for splitting said adapter T-parameter matrix into respective first ( $T_{a11}$ ), second ( $T_{a12}$ ), third ( $T_{a21}$ ), and fourth ( $T_{a22}$ ) T-parameter sub-matrix and solving for said cascaded S-parameter matrix using the equation:

$$(T_{a11}S_D + T_{a12})(T_{a21}S_D + T_{a22})$$

43. (Original) An apparatus as recited in claim 39 wherein said number of device ports on said embedded device is odd.
44. (Original) An apparatus as recited in claim 43 wherein said means for establishing said adapter T-parameter matrix further comprises means for modeling said device with an additional device port and including as part of said values in said adapter T-parameter matrix a zero length, loss-less transmission line connected to said additional device port and terminated in a perfect load.

CLAIMS 45-57 CANCELED



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58. (Amended) An article of manufacture comprising computer readable storage media including computer software embedded therein that causes a processing unit to perform the method comprising the steps of:

obtaining a device S-parameter matrix ( $S_D$ ) having matrix elements that characterize high frequency behavior of said device, said device having a number of device ports,

establishing a single adapter T-parameter matrix ( $T_a$ ) having matrix elements that represent transmission parameters for all possible paths in a combination of the one or more circuits,

partitioning said adapter T-parameter matrix into four sub-matrices, and

solving for a cascaded S-parameter matrix ( $S_c$ ) that represents the one or more circuits cascaded with the device as a function of said four sub-matrices and said device S-parameter matrix, ~~and~~

~~verifying resulting values in said cascaded S-parameter matrix against a desired result.~~

59. An article of manufacture as recited in claim 58 and further comprising the step of preparing a design for the device embedded in electrical context with said one or more circuits.

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60. An article of manufacture as recited in claim 58 wherein a model for said one or more circuits has twice said number of device ports.

61. An article of manufacture as recited in claim 60 wherein said step of partitioning comprises splitting said adapter T-parameter matrix into respective first ( $T_{a11}$ ), second ( $T_{a12}$ ), third ( $T_{a21}$ ), and fourth ( $T_{a22}$ ) T-parameter sub-matrix and solving for said cascaded S-parameter matrix using the equation:

$$(T_{a11}S + T_{a12})(T_{a21}S + T_{a22})$$

62. An article of manufacture as recited in claim 58 wherein said device has an odd number of device ports.

63. An article of manufacture as recited in claim 62 wherein said step of establishing said adapter T-parameter matrix comprises modeling said device with an additional device port and including as part of said adapter T-parameter matrix a representation of electrical behavior of a zero length, loss-less transmission line connected to said additional device port and terminated in a perfect load.

64. (Newly Added) A method of predicting as recited in claim 14 and further comprising the step of verifying resulting values in said cascaded S-parameter matrix against a desired result.

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65. (Newly Added) An article of manufacture as recited in claim 58 and further comprising the step of verifying resulting values in said cascaded S-parameter matrix against a desired result.